

**REPLY UNDER 37 CFR 1.116  
EXPEDITED PROCEDURE  
TECHNOLOGY CENTER 2800**

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

<b>Applicants:</b>	Chudzik et al.	<b>Conf. No.:</b>	4946
<b>Serial No.:</b>	10/710,947	<b>Art Unit:</b>	2831
<b>Filing Date:</b>	08/13/2004	<b>Examiner:</b>	He, Amy
<b>Title:</b>	METHODS FOR THE DETERMINATION OF FILM CONTINUITY AND GROWTH MODES IN THIN DIELECTRIC FILM	<b>Docket No.:</b>	FIS920040092US2 (IBMF-0066)

Mail Stop Amendment  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**AFTER FINAL AMENDMENT**

Sir:

**I. INTRODUCTORY COMMENTS:**

In response to the Final Office Action mailed on April 15, 2008, Applicants proposes to amend the above-referenced patent application as follows:

**Amendments to the claims are shown on page 3 of this response.**

**Remarks** begins on page 7 of this response.